## **Supplementary Information**

# Dichlorine-containing chlorobismuthate(III) supramolecular hybrid: structure and experimental studies of stability

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### Synthetic procedures

All reagents were obtained from commercial sources and used without additional purification. **Caution:** All experiments with dichlorine require obligatory use of fume hood and presence of adequate exhaust ventilation, as well as eye (goggles) and skin (gloves) protection.

### Synthesis of 1

93.2 mg (0.2 mmol) of  $Bi_2O_3$  and 44 mg (0.4 mmol) of  $Me_4NCI$  were dissolved in 4 ml of concentrated HCI and heated to 60°C. At this temperature, excess of dichlorine was bubbled through the solution for 5 min. Solution was filtered and  $Cl_2$  was bubbled for another 5 min. Then the vial was closed and slowly cooled to 5°C. Within one day, there form transparent crystals of **1**. Yield: 69%. For  $C_{12}H_{36}Bi_2Cl_{11}N_3$  calcd, %: C, 14.05; H, 3.54; N, 4.10; found, %: C, 14.06; H, 3.58; N, 4.11.

#### X-ray Diffractometry

Crystallographic data and refinement details for **1** are given in Table S1. The diffraction data were collected on a Bruker D8 Venture diffractometer with a CMOS PHOTON III detector and I $\mu$ S 3.0 source (Mo K $\alpha$  radiation,  $\lambda$  = 0.71073 Å) at 150 K. The  $\phi$ - and  $\omega$ -scan techniques were employed. Absorption correction was applied by SADABS (Bruker Apex3 software suite: Apex3, SADABS-2016/2 and SAINT, version 2018.7-2; Bruker AXS Inc.: Madison, WI, 2017.). Structures were solved by SHELXT[1] and refined by full-matrix least-squares treatment against  $|F|^2$  in anisotropic approximation with SHELX 2014/7[2] in ShelXle program.[3] H-atoms were refined in the geometrically calculated positions. The crystallographic data have been deposed in the Cambridge Crystallographic Data Centre under the deposition codes CCDC 2141780.

- [1] G.M. Sheldrick, Acta Crystallogr. Sect. A Found. Adv. 71 (2015) 3–8.
- [2] G.M. Sheldrick, Acta Crystallogr. Sect. C Struct. Chem. 71 (2015) 3–8.
- [3] C.B. Hübschle, G.M. Sheldrick, B. Dittrich, J. Appl. Crystallogr. 44 (2011) 1281–1284.

	1
Chemical formula	C <sub>12</sub> H <sub>36</sub> Bi <sub>2</sub> Cl <sub>11</sub> N <sub>3</sub>
M <sub>r</sub>	1030.35
Crystal system, space group	Hexagonal, P6 <sub>3</sub> /mmc
Temperature (K)	150
<i>a, c</i> (Å)	9.1792 (3), 21.9776 (10)
V (Å <sup>3</sup> )	1603.69 (13)
Z	2
Radiation type	Mo Ka
μ (mm <sup>-1</sup> )	11.88
Crystal size (mm)	0.12 × 0.10 × 0.04
Diffractometer	Bruker D8 Venture
	diffractometer
Absorption correction	Multi-scan
	SADABS 2016/2: Krause, L., Herbst-Irmer, R.,
	Sheldrick G.M. & Stalke D., J. Appl. Cryst. 48 (2015)
	3-10
$T_{\min}, T_{\max}$	0.524, 0.746
No. of measured, independent and	16530, 621, 615
observed $[l > 2\sigma(l)]$ reflections	
R <sub>int</sub>	0.110
θ values (°)	$\theta_{max}$ = 25.7, $\theta_{min}$ = 2.6
(sin θ/λ) <sub>max</sub> (Å <sup>-1</sup> )	0.609
Range of <i>h</i> , <i>k</i> , <i>l</i>	$-11 \le h \le 11, -11 \le k \le 11, -26 \le l \le 26$
$R[F^2 > 2\sigma(F^2)], wR(F^2), S$	0.061, 0.141, 1.45
No. of reflections, parameters,	621, 50, 94
restraints	
H-atom treatment	H-atom parameters constrained
Weighting scheme	$w = 1/[\sigma^2(F_o^2) + 50.5902P]$ where $P = (F_o^2 + 2F_c^2)/3$
Dρ <sub>max</sub> , Dρ <sub>min</sub> (e Å <sup>-3</sup> )	1.76, -2.46

Computer programs: *APEX3* (Bruker-AXS, 2016), *SAINT* (Bruker-AXS, 2016), *SHELXT* 2014/5 (Sheldrick, 2014), *SHELXL2017*/1 (Sheldrick, 2017).

#### Powder X-ray diffractometry

XRD analysis of polycrystals was performed on Shimadzu XRD-7000 diffractometer (CuK-alpha radiation, Ni – filter, linear One Sight detector,  $5 - 50^{\circ} 2\theta$  range,  $0.0143^{\circ} 2\theta$  step, 2s per step). A polycrystalline sample was slightly ground with hexane in an agate mortar, and the resulting suspension was deposited on the polished side of a standard quartz sample holder, and a

smooth thin layer being formed after drying. Plotting of PXRD patterns and data treatment was performed using X'Pert Plus software.



Figure S1. Theoretical (blue) and experimental (red) PXRD patterns for 1



**Figure S2.** Experimental PXRD pattern (red) of the sample of **1** after TGA thermostatic experiment (140°C, ≈40 min) compared to theoretical pattern of **1** (blue)



**Figure S3.** Experimental PXRD pattern (red) of the sample of **1** after TGA thermostatic experiment (140°C,  $\approx$ 40 min) compared to theoretical pattern of TMA<sub>3</sub>[Bi<sub>2</sub>Cl<sub>9</sub>] (blue)

#### Raman spectroscopy

Raman spectra were collected using a LabRAM HR Evolution (Horiba) spectrometer with the excitation by the 633 nm line of the He-Ne laser. The spectra at room temperatures were obtained in the backscattering geometry with a Raman microscope. The laser beam was focused to a diameter of 2 micrometers using a LMPlan FL 50x/0.50 Olympus objective. The spectral resolution was 0.7 cm<sup>-1</sup>. The laser power on the sample surface was about 0.03 mW.

**Thermogravimetric analyses (TGA)** were carried out on a TG 209 F1 Iris thermobalance (NETZSCH, Germany). The measurements were made in a helium flow in the temperature range of 30–450°C using the heating rate of 10°C min<sup>-1</sup> the gas flow rate of 60 mL min<sup>-1</sup> and open Al crucibles.